Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/046 263	FUKUOKA ET AI

Examiner

Thai D. Hoang

Art Unit

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INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST: updated text search all database, see search history printout.	8/14/2006	тн		
EAST: interference search: text search PG-PUB data base, see search history printout.	8/14/2006	тн		
NPL: IEEE, IETF AND GOOGLE	8/14/2006	тн		
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